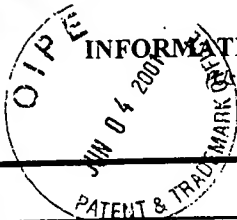


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INFORMATION DISCLOSURE STATEMENT

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Bucket Number (Optional)

200-1452

Application Number

09/08/732

Applicant(s)

Paul J. Stewart et al.

Filing Date

5-30-01

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~~Concurrently Herewith~~

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*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
THS		4,821,214	04/11/1989	Sederberg	345	420	
THS		5,119,309	06/02/1992	Cavendish et al.	700	182	
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	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

THS		Duane S. Boning and P. K. Mozumder, "DOE/Opt: A system For Design Of Experiments, Response Surface Modeling, Optimization Using Process And Device Simulation", Semiconductor Process and Design Center, December 7, 1993. P3
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EXAMINER

Sam Stewart

DATE CONSIDERED

9/10/01

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Applicants: Paul J. Stewart et al.	
FILING May 30, 2001	GROUP 2123

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
THY	5,459,382	10/17/1995	Jacobus et al.	315	568.11	
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER <i>Don Duer</i>	DATE CONSIDERED <i>THY</i>
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